

# Electrochemical Deposition of Thermoelectric Nanowire Arrays on Silicon

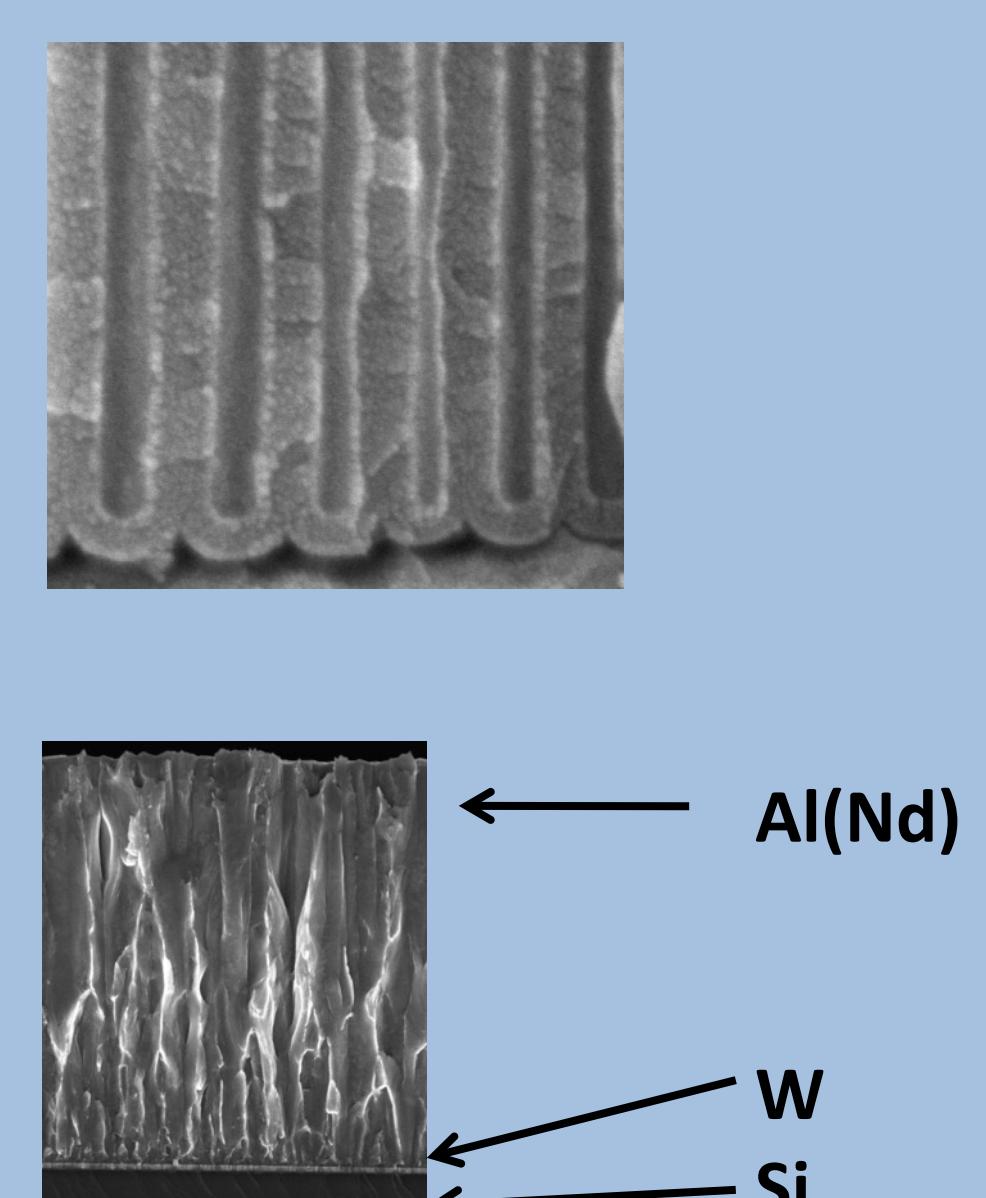
Steven J. Limmer<sup>1</sup>, W. Graham Yelton<sup>1</sup>, Michael P. Siegal<sup>1</sup>, Jessica L. Lensch-Falk<sup>2</sup>, Alexandra C. Ford<sup>2</sup>, Douglas L. Medlin<sup>2</sup>  
 Sandia National Laboratories, <sup>1</sup>Albuquerque NM and <sup>2</sup>Livermore CA

SAND2012-5933C

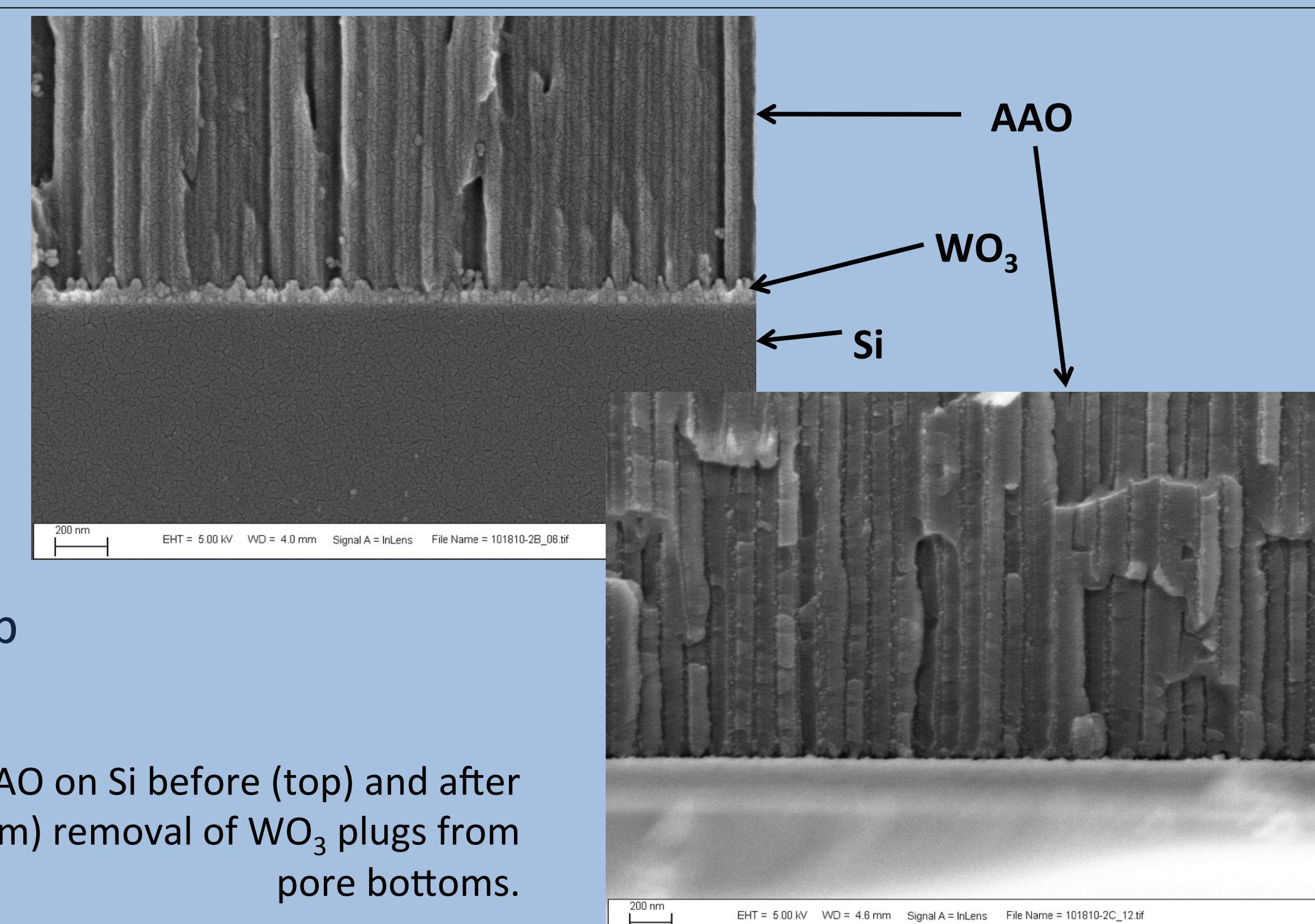
Thermoelectric (TE) nanowires have great promise, but by large they are not ready to be incorporated into real devices. This is mainly due to a lack of compositional and structural control that leads to poor TE performance. TE nanowire arrays deposited directly onto Si have benefits both for characterization (uniformity, controlled length) and future device integration. This poster describes our recent work in fabricating arrays of  $\text{Bi}_2\text{Te}_3$  and  $\text{Bi}_2(\text{Te},\text{Se})_3$  nanowires directly on Si substrates.

## Fabricating anodic aluminum oxide (AAO) templates on Si:

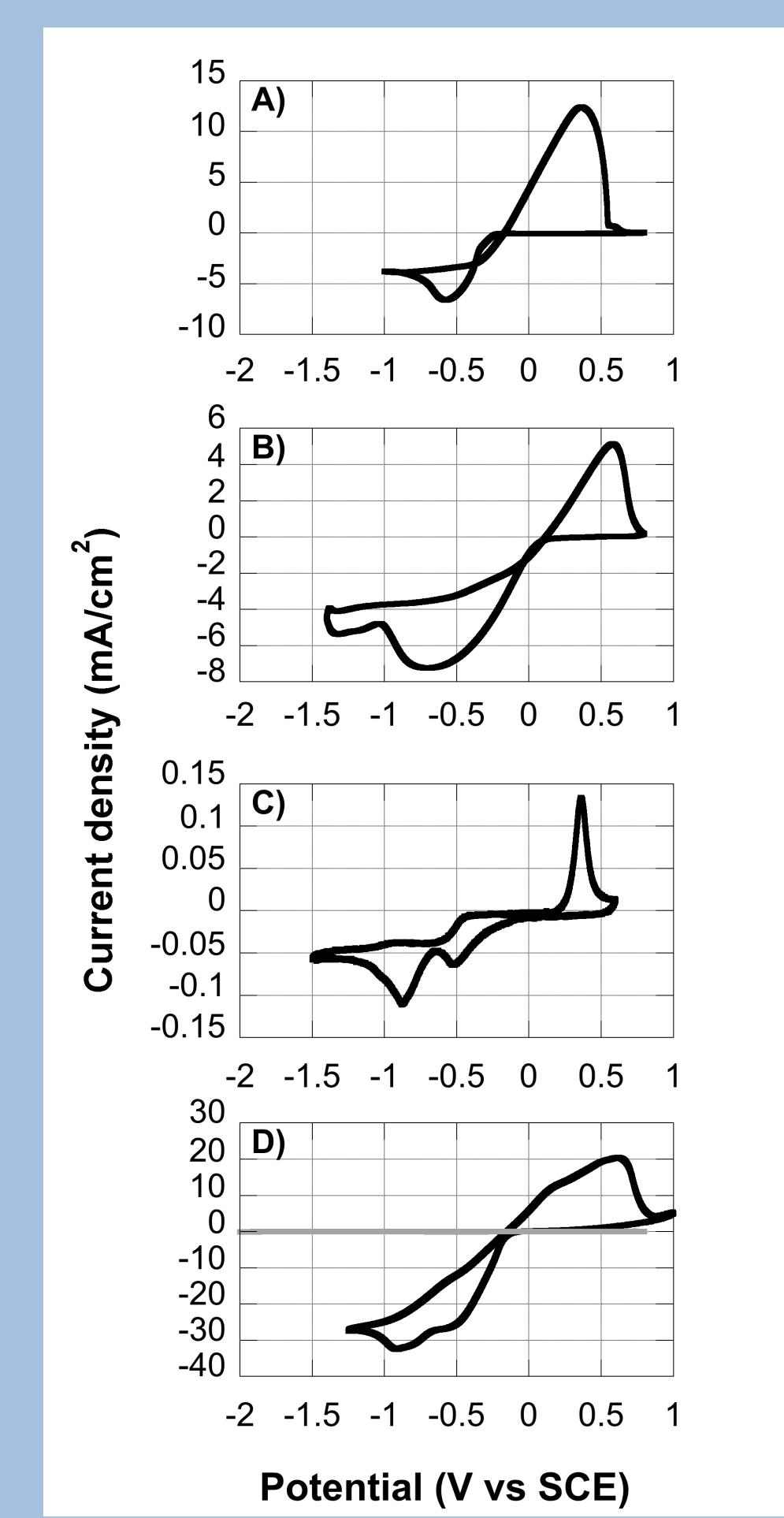
- Pores in AAO tend to have a “test-tube” shape; open at one end with an oxide cap at the other end
- This barrier oxide interferes with electrodeposition
- Attempts to form AAO directly on a conductive substrate (Au, Si, ITO...) tend to delaminate
- Using a valve metal layer (e.g. W, Nb, Ta) under the Al alleviates this problem



- The W oxidizes to form a “plug” of  $\text{WO}_3$  at the pore bottom
- $\text{WO}_3$  “plugs” can be selectively etched, leaving pores open at both ends
- With the pore bottoms opened, it is possible to electrodeposit nanowire arrays directly on the Si
- By carefully controlling the film stress, we have made AAO with pores up to  $\sim 10 \mu\text{m}$  depth

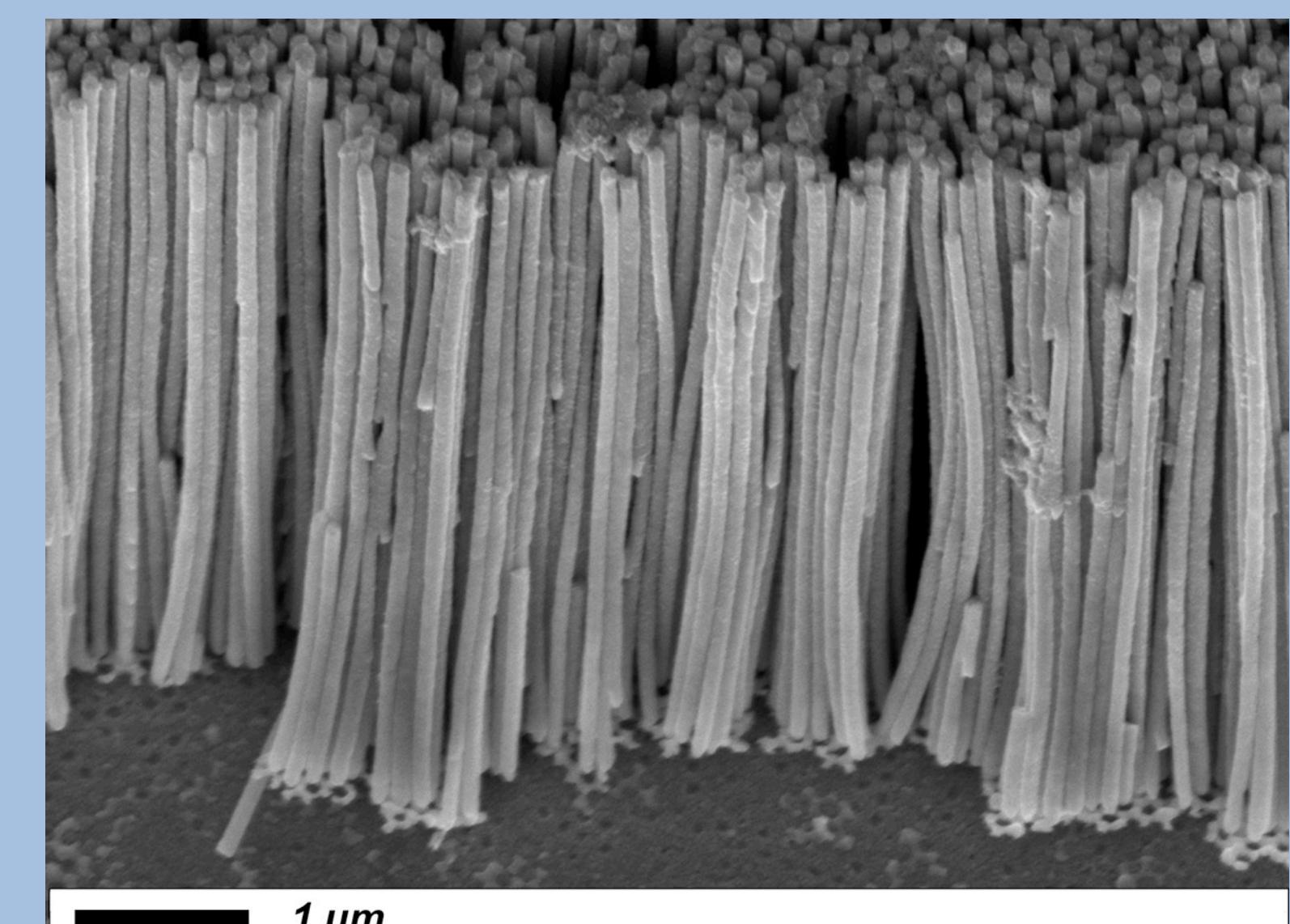


## Electrodeposition of $\text{Bi}_2(\text{Te},\text{Se})_3$ on Si: Pulsed galvanostatic ECD from a non-aqueous (DMSO) bath

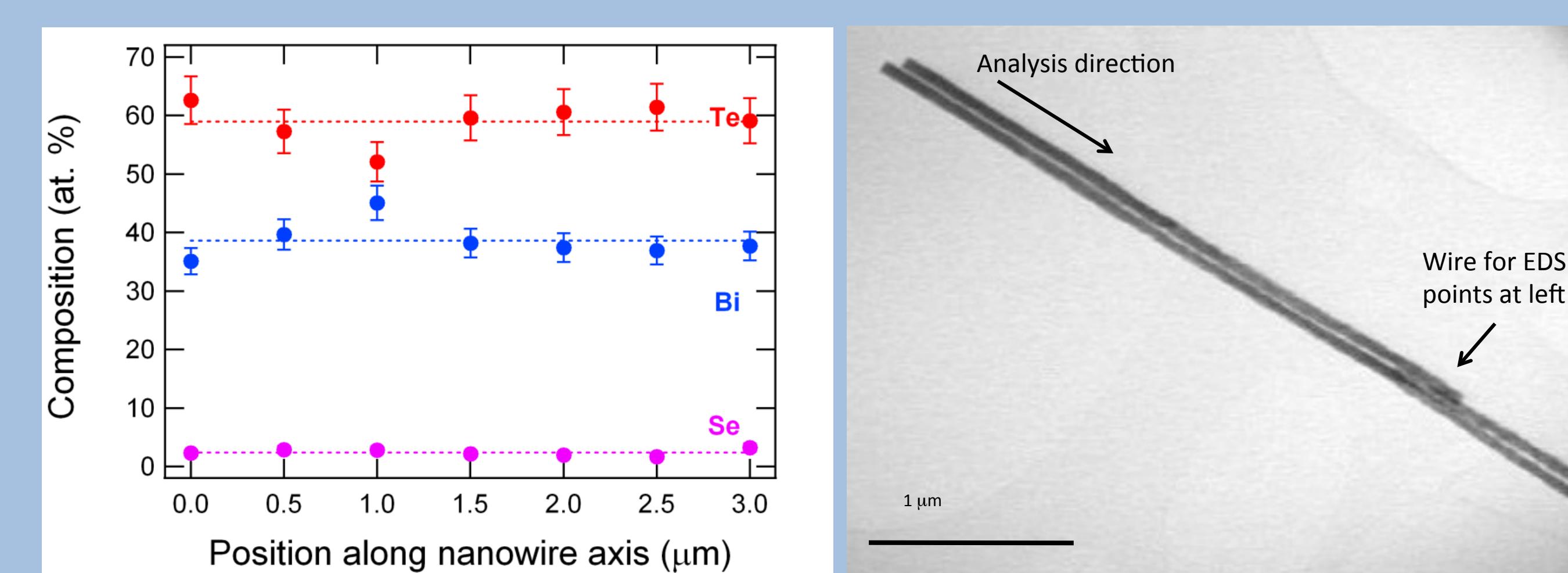


CV scans of the bath components (with 0.1 M  $\text{KClO}_4$  supporting electrolyte) at 10 mV/s on Pt disk electrodes. A) 80 mM  $\text{Bi}(\text{NO}_3)_3$ , B) 60 mM  $\text{TeCl}_4$ , C) 1 mM  $\text{SeO}_2$ , D) Full bath (80 mM  $\text{Bi}(\text{NO}_3)_3$ , 60 mM  $\text{TeCl}_4$ , 1.1 mM  $\text{SeO}_2$  and 0.1 M  $\text{KClO}_4$ ) in black, and background (0.1 M  $\text{KClO}_4$ ) in gray.

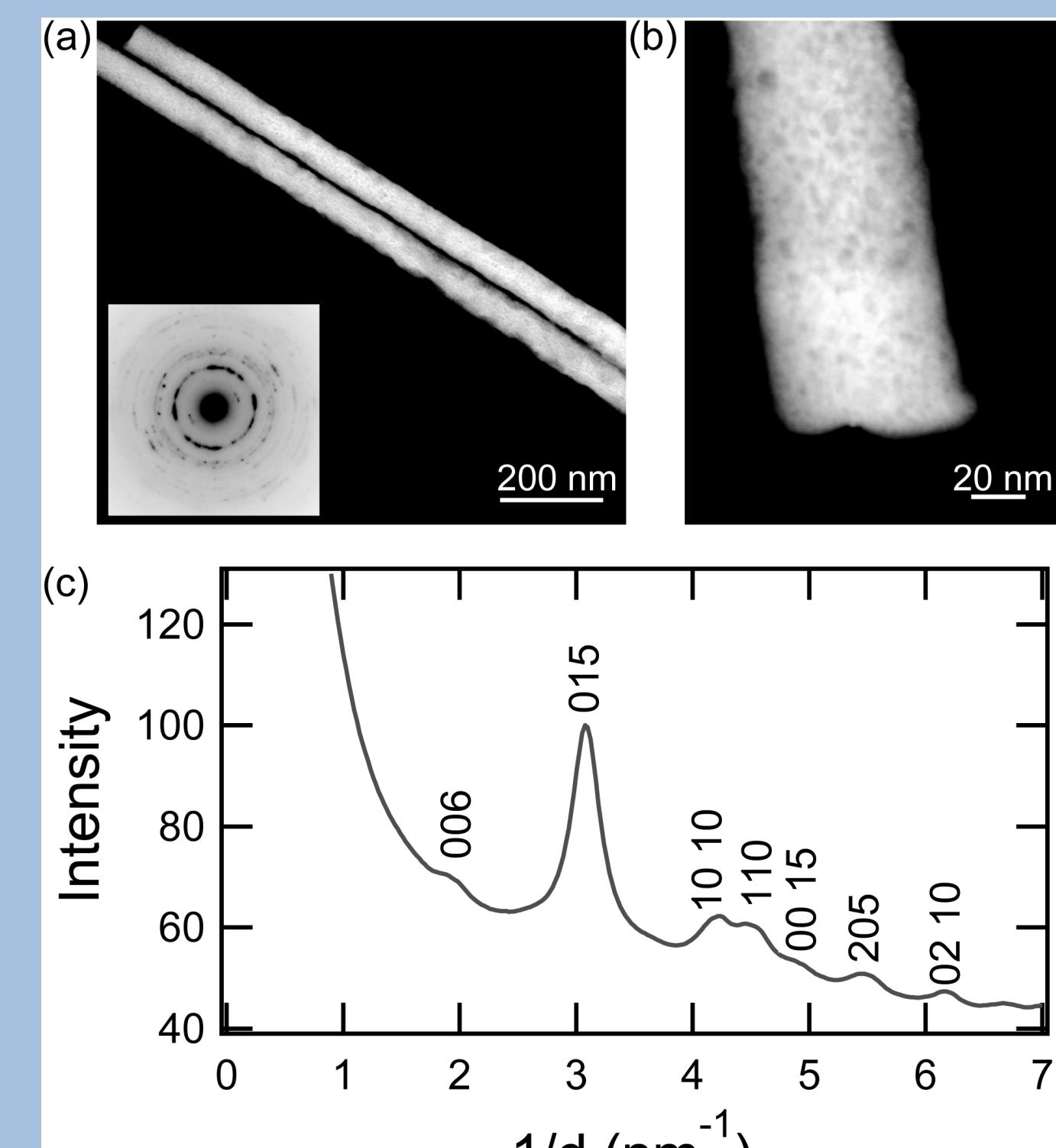
Deposition at  $-10 \text{ mA/cm}^2$  with 500 ms pulses (1 s off) from an 80 mM  $\text{Bi}(\text{NO}_3)_3$ , 60 mM  $\text{TeCl}_4$  and 1.1 mM  $\text{SeO}_2$  bath yields nanowires of nominal composition  $\text{Bi}_2(\text{Te}_{0.95}\text{Se}_{0.05})_3$



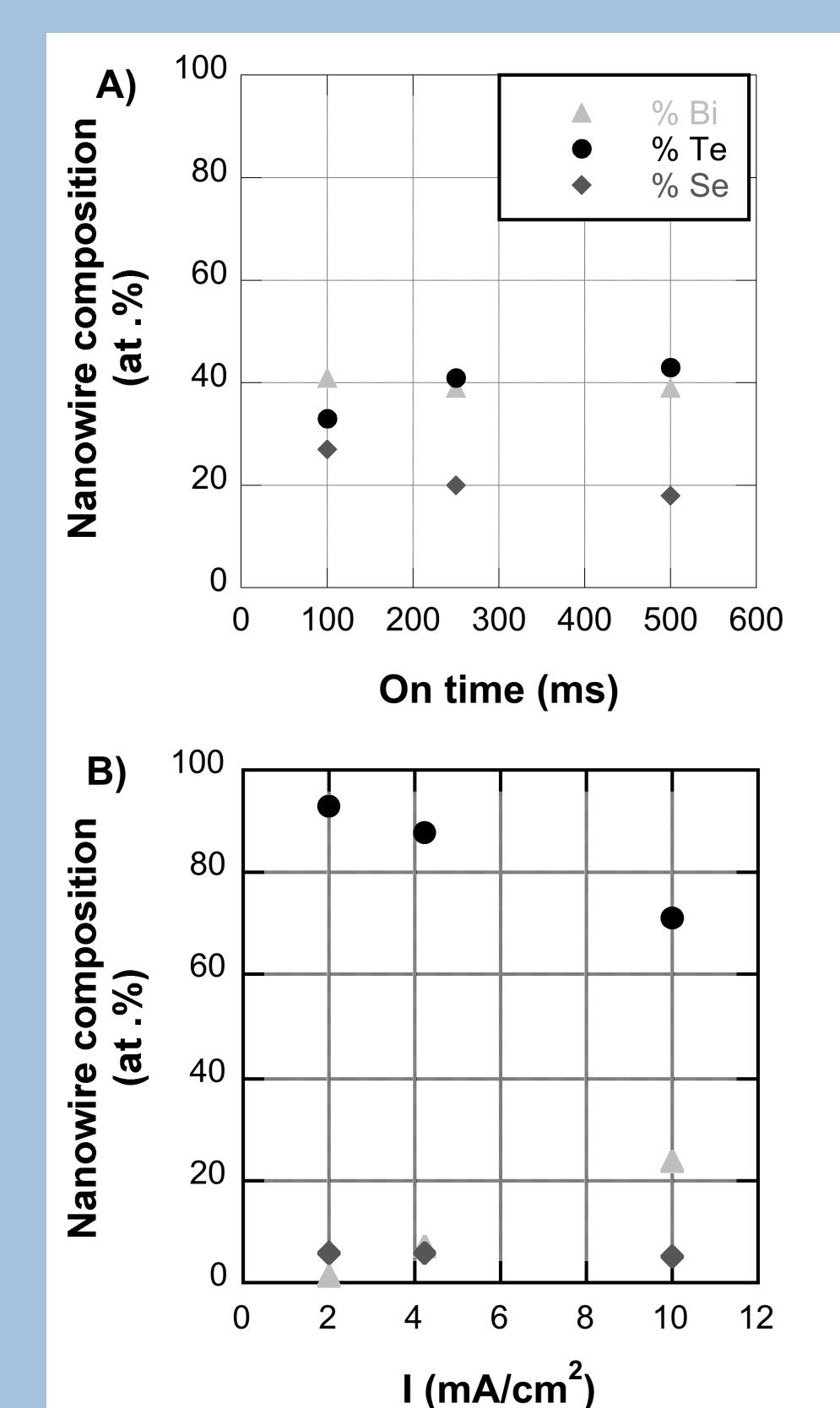
SEM image of  $\text{Bi}_2(\text{Te},\text{Se})_3$  nanowires on Si. These nanowires are  $\sim 75 \text{ nm}$  in diameter and  $\sim 5 \mu\text{m}$  long.



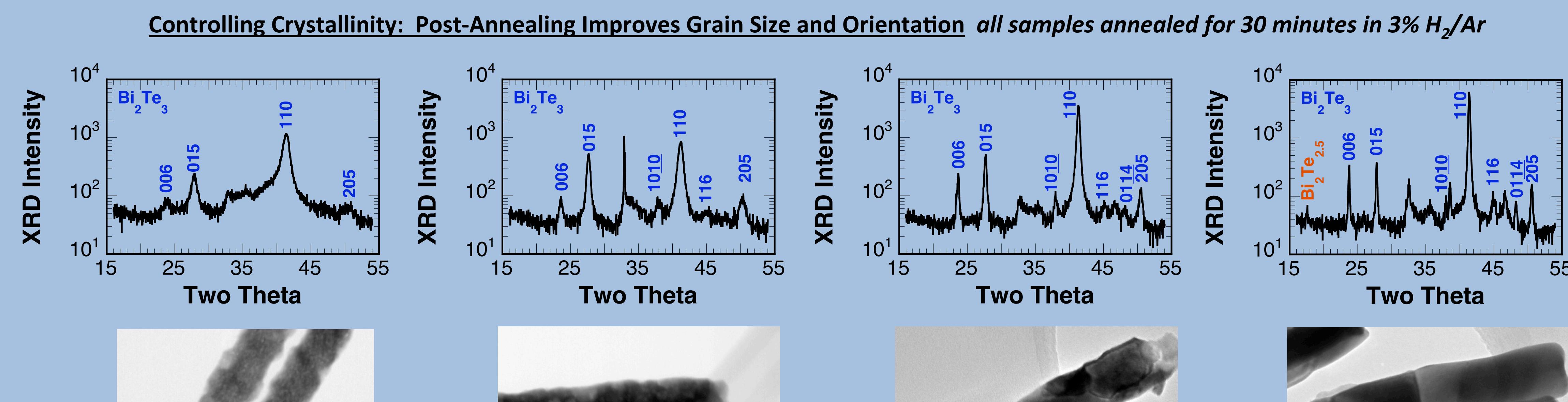
Composition along the length of an individual nanowire measured by STEM/EDS. Dotted lines show the overall average composition of a number of nanowires.



HAADF STEM images of  $\text{Bi}_2(\text{Te},\text{Se})_3$  nanowires showing a polycrystalline structure. The inset in (a) is the SAED pattern for these nanowires, which confirms that the nanowires are polycrystalline. (c) The azimuthal average of the SAED pattern in (a) is indexed and indicates that the material has the  $\text{Bi}_2\text{Te}_3$  tetradymite crystal structure.



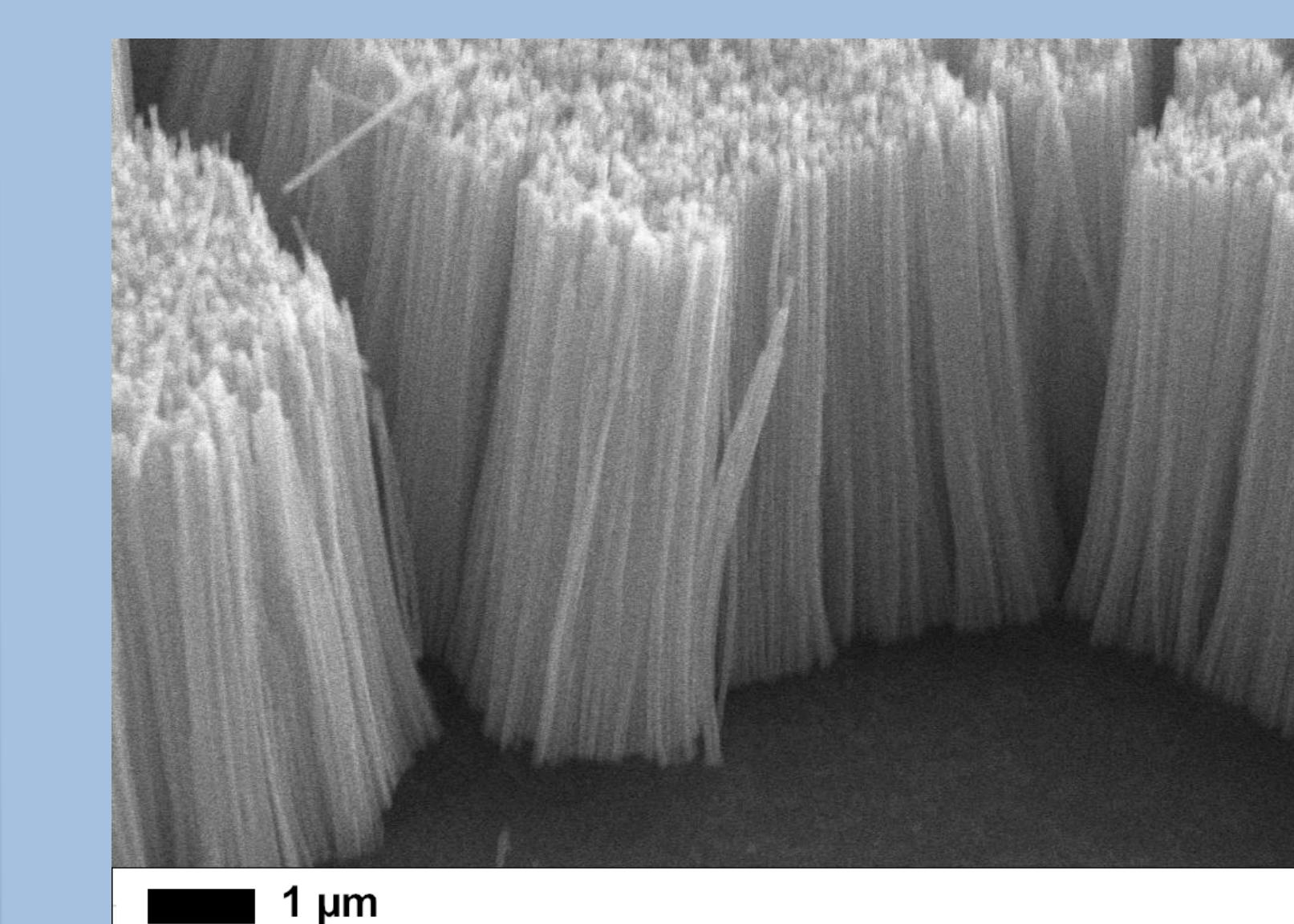
Nanowire composition is influenced by bath, pulse time and current density. A) Influence of “on” time on the nanowire composition ( $2 \text{ mA/cm}^2$  in a bath with 80 mM  $\text{Bi}^{3+}$ , 40 mM  $\text{Te}^{4+}$  and 1.2 mM  $\text{Se}^{4+}$ ). B) Influence of current density on the nanowire composition (500 ms “on” time in a bath with 80 mM  $\text{Bi}^{3+}$ , 80 mM  $\text{Te}^{4+}$  and 1.0 mM  $\text{Se}^{4+}$ ).



As deposited 5-10 nm grains  
 200 °C anneal 20-40 nm grains  
 300 °C anneal grains 56 x 98 nm to 250 nm x full width  
 400 °C anneal grains 74 x 145 nm to 320 nm x full width

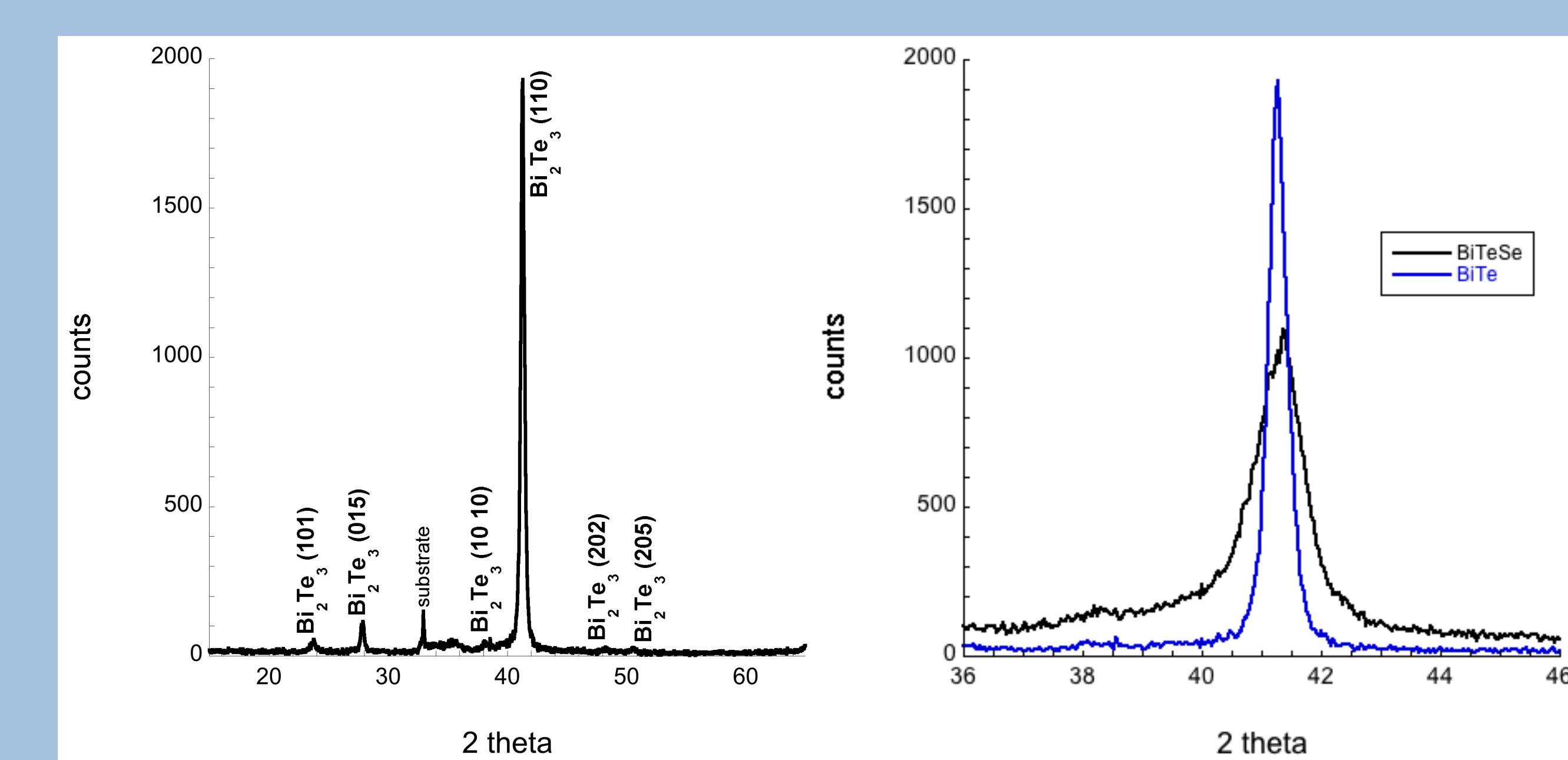
## Electrodeposition of $\text{Bi}_2\text{Te}_3$ on Si: Pulsed galvanostatic ECD from an aqueous bath

Deposition at  $-20 \text{ mA/cm}^2$  with 100 ms pulses (0.9 s off) from 6 mM  $\text{Bi}(\text{NO}_3)_3$  and 7 mM  $\text{Na}_2\text{TeO}_3$  in 0.3 M tartaric acid + 2M  $\text{HNO}_3$  yields nanowires of nominal composition  $\text{Bi}_2\text{Te}_3$



SEM image of  $\text{Bi}_2\text{Te}_3$  nanowires on Si. These nanowires are  $\sim 75 \text{ nm}$  in diameter and  $\sim 6 \mu\text{m}$  long.

These nanowires are very uniform in length. Pulsed potentiostatic deposition from this bath yielded a less uniform length distribution.



Nanowires from this bath have a more pronounced (110) orientation. Sharper XRD peaks imply a larger grain size than in the  $\text{Bi}_2(\text{Te},\text{Se})_3$  nanowires

Measurements of single nanowires (annealed at 200 °C) show a resistivity of  $\sim 1.5 \times 10^{-3} \Omega\text{-cm}$ , which is comparable to bulk values.

